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U.S. Depar	tment c	of Commerce, Pat	ent	and Trader	mai	k Office	Docket		Sheet 1 of 2 s	si ieei(s	
U.S. Department of Commerce, Patent and Trademark Office (PTO Form 1449 modified)							AMAT/5730/TCG/ WCVD/LE		10/023,125		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT								Applicant		Confirmation No.:	
(MAY 1	5 2003	Yoo, et al.		4585						
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		Examiner Unk	Dec. 17, 2001		Unknown						
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/F.S./	A1	6,534,395	03/18/03		Werkhoven, et al.		438	627	03/06/01		
/F.S./	A2	6,482,262	11	1/19/02	Elers, et al.		117	84	10/13/00		
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Initial		Number							YES	NO	
/F.S./	B1	02/45167	06/06/02			wo	H01L	27/00			
/F.S./	B2	02/067319	08/29/02			wo	H01L	21/768			
/F.S./	В3	98/51838		11/19/98	wo		C23C	16/06			
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/F.S./	A1	2002/0187256	12/12/02	E	lers, et al.	427	99	07/30/02			
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		Number						YES	NO		
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.

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